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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/604,862	08/22/2003	Ming-Yang Chao	MTKP0032USA	1861
27765	7590	08/01/2006	EXAMINER	
NORTH AMERICA INTELLECTUAL PROPERTY CORPORATION P.O. BOX 506 MERRIFIELD, VA 22116			GUPTA, PARUL H	
		ART UNIT	PAPER NUMBER	
		2627		

DATE MAILED: 08/01/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

<b>Office Action Summary</b>	<b>Application No.</b>	<b>Applicant(s)</b>	
	10/604,862	CHAO, MING-YANG	
	<b>Examiner</b>	<b>Art Unit</b>	
	Parul Gupta	2627	

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

#### Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER, FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

#### Status

- 1) Responsive to communication(s) filed on 7/19/06.
- 2a) This action is FINAL.                    2b) This action is non-final.
- 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

#### Disposition of Claims

- 4) Claim(s) 1 and 4-18 is/are pending in the application.
- 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.
- 5) Claim(s) \_\_\_\_\_ is/are allowed.
- 6) Claim(s) 1 and 4-18 is/are rejected.
- 7) Claim(s) \_\_\_\_\_ is/are objected to.
- 8) Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

#### Application Papers

- 9) The specification is objected to by the Examiner.
- 10) The drawing(s) filed on \_\_\_\_\_ is/are: a) accepted or b) objected to by the Examiner.  
Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).  
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

#### Priority under 35 U.S.C. § 119

- 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) All    b) Some \* c) None of:
  1. Certified copies of the priority documents have been received.
  2. Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.
  3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).

\* See the attached detailed Office action for a list of the certified copies not received.

#### Attachment(s)

- |   |   |
|---|---|
| 1) <input type="checkbox"/> Notice of References Cited (PTO-892)  | 4) <input type="checkbox"/> Interview Summary (PTO-413)                     |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948)                                    | Paper No(s)/Mail Date. _____  |
| 3) <input type="checkbox"/> Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)<br>Paper No(s)/Mail Date _____. | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
|   | 6) <input type="checkbox"/> Other: _____.                                   |

## DETAILED ACTION

1. Claims 1-18 are pending for examination as interpreted by the examiner. The amendment filed on 7/19/06 was considered.

### ***Claim Rejections - 35 USC § 103***

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

2. Claims 1-7 and 9-18 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kaku et al., US Patent 6,414,932, in view of Kato et al., US Patent 6,775,217.

Regarding claim 1, Kaku et al. teaches a high-speed optical recording apparatus in an optical storage device for generating a write signal according to an RLL modulation waveform (NRZ signal) inputted to the high-speed optical recording apparatus, so as to control a writing power of a pickup in the optical storage device (see abstract), the recording apparatus comprising: a clock generator (modulation circuit of element 7 in figure 2) for generating a first clock signal (chCLK); an adjustment data storage unit (part of the write strategy control unit of element 104 of figure 2) for storing a plurality of sets of write strategy parameters, and selecting and outputting a corresponding set of write strategy parameters from plurality of the sets of write strategy parameters according to the RLL modulation waveform (explained in column 5, lines 40-54); a rough delay unit (delay circuit of element 114 of figure 2) electrically connected to the clock generator to receive the first clock signal, and further electrically connected to

the adjustment data storage unit to receive the selected set of write strategy parameters, the rough delay unit (element 114 of figure 2) for generating a fine delay parameter according to the selected set of write strategy parameters, and for delaying the RLL modulation waveform according to the first clock signal and the selected set of write strategy parameters to generate a first delay signal (column 2, lines 38-40). Kaku et al. teaches the high-speed optical recording apparatus wherein the RLL modulation waveform is an NRZI modulation waveform (the NRZ modulation waveform serves the same purpose), the apparatus generating the write signal according to an encoded modulation bits (column 5, lines 40-54 explains that the write signal is based on the NRZ modulation waveform). Kaku et al. also teaches the use of a NRZI waveform. Kaku et al. teaches in figure 2 the high-speed optical recording apparatus of claim 2 wherein the clock generator further generates a second clock signal (SCLK outputted from element 6), the recording apparatus further comprising: a delay adjustment state machine (part of element 114) electrically connected to the clock generator to receive the second clock signal (received through the output of the serial interface unit of element 100), and further electrically connected to the adjustment data storage unit (part of write strategy of element 104) to receive the selected set of write strategy parameters, the delay adjustment state machine (element 114 of figure 2) for generating a rough delay parameter and the fine delay parameter according to the selected set of write strategy parameters, and for delaying the NRZI modulation waveform according to the second clock signal and the set of write strategy parameters so as to generate a second delay signal (column 2, lines 38-40).

Kaku et al. does not but Kato et al. teaches in figure 3 a fine delay chain (element 324) electrically connected to the rough delay unit (element 322) to receive the first delay signal and the fine delay parameter, the fine delay chain for delaying the first delay signal according to the fine delay parameter so as to generate the write signal (column 5, lines 6-19), the fine delay chain having a plurality of serially connected delay cells, each delay cell delaying the first delay signal by a predetermined period (column 5, lines 41-56). Kato et al. also teaches a rough delay counter or a rough delay shift register (element 322) electrically connected to the clock generator (element 320) to receive the first clock signal, and further electrically connected to the delay adjustment state machine (duties performed by the "write strategy delay table" of element 350) to receive the rough delay parameter (N1) and the second delay signal for delaying the second delay signal according to the first clock signal and the rough delay parameter so as to generate the first delay signal.

Therefore, It would have been obvious to one of ordinary skill in the art at the time of the invention to modify the delay circuit of Kaku et al. of an optical recording apparatus by including the fine delay chain and specific parameters as taught by Kato et al. for the purpose of helping to accurately generate delays in write pulses at high speeds (column 2, lines 24-31 of Kato et al.).

Kaku et al. teaches the limitations of claims 4, 5, 10, 12-16, and 18.

Regarding claim 4, Kaku et al. teaches the high-speed optical recording apparatus wherein clock generator comprises a phase locked loop for generating the

first clock signal (element 115 of figure 2), and a frequency divider for dividing a frequency of the inputted first clock signal to generate the second clock signal (SCLK outputted from element 6 of figure 2). For further explanation, see column 2, lines 18-32 and column 6, lines 44-49.

Regarding claim 5, Kaku et al. teaches in figure 3 the high-speed optical recording apparatus wherein a period of the second clock signal (CLK SIGNAL) is equal to a base period of the RLL modulation waveform (NRZ SIGNAL). The equivalence is shown in figure 3 (ii) as compared to figure 3 (iv).

Regarding claim 10, Kaku et al. teaches the high-speed optical recording apparatus further comprising an NRZI input interface (write strategy control unit of element 104 of figure 2) for receiving the NRZI modulation waveform and generating an address signal ("timing signal" as explained in column 5, lines 40-46 serves the same purpose).

Regarding claim 12, Kaku et al. teaches the high-speed optical recording apparatus of claim 10 wherein the rough delay unit (element 114 of figure 2) is electrically connected to the NRZI input interface to receive the NRZI modulation waveform (shown in figure 2).

Regarding claim 13, Kaku et al. teaches in column 5, lines 36-46, the high-speed optical recording apparatus of claim 10 wherein the adjustment data storage unit (consists of the Pa-Pd registers) is electrically connected to the EFM input interface (write strategy control unit) to receive the address signal (timing signal) for selecting the corresponding write strategy parameter according to the address signal.

Regarding claim 14, Kaku et al. teaches in figure 2 the high-speed optical recording apparatus of claim 2 further comprising a data storage setting interface (duties performed by the “write strategy control unit” of element 104) electrically connected to the adjustment data storage unit (registers Pa-Pd, elements 106-109), and further electrically connected to a microprocessor of the optical storage device (through the “modulation ckt” of element 7, which is connected to the host computer of the optical storage device as shown in figure 1) to receive the sets of write strategy parameters (various recording powers) and storing the sets of write strategy parameters into the adjustment data storage unit.

Regarding claim 15, Kaku et al. teaches the high-speed optical recording apparatus of claim 2 wherein the adjustment data storage unit is a volatile memory. As the adjustment data storage unit given in Kaku et al. consists of various registers (Pa-Pd as given in figure 2), the unit as a whole is a type of volatile memory.

Regarding claim 16, Kaku et al. teaches the high-speed optical recording apparatus wherein the delay cells are a plurality of serially connected inverters or buffers (the differential amplifiers of figure 5 serve this purpose as is explained in column 6, lines 1-10), the fine delay chain further comprising a multiplexer for selecting the write signal from a plurality of outputs of the inverters or buffers (the selection method given in column 4, lines 41-53 serves the same purpose).

Regarding claim 18, Kaku et al. teaches the high-speed optical recording apparatus of claim 2 wherein the EFM modulation waveform is generated by an EFM encoder of the optical storage device (column 4, lines 3-5 explain that the EFM code

corresponds to the CD format, suggesting that the EFM code unique to the format is generated by the optical storage device).

Kaku et al. does not but Kato et al. teaches the limitations of claims 6-7, 9, 11, and 17.

Regarding claim 7, Kato et al. teaches in column 2, lines 37-40, the high-speed optical recording apparatus wherein a resolution of the delay adjustment state machine delaying the RLL modulation waveform (amount of delay for the EFM data pulse edges) is equal to a period of the second clock signal (code rate clock).

Regarding claim 9, Kato et al. teaches the high-speed optical recording apparatus wherein a resolution of the rough delay counter delaying the second delay signal is equal to a period of the first clock signal (column 2, lines 49-55).

Regarding claim 17, Kato et al. teaches in column 2, lines 59-63, the high-speed optical recording apparatus wherein a resolution of the fine delay chain delaying the first delay signal is equal to the predetermined period ( $T_{efm}/(2^*N*M)$ ).

It would have been obvious to one of ordinary skill in the art at the time of the invention to include the delay elements of Kato et al. into the delay circuit of Kaku et al. This serves the purpose of helping to accurately generate delays in write pulses at high speeds (column 2, lines 24-31 of Kato et al.).

Regarding claim 6, Kato et al. teaches the high-speed optical recording apparatus wherein a period of the second clock signal is equal to a multiple of a period of the first clock signal (column 6, lines 37-44).

Regarding claim 11, Kato et al. teaches the high-speed optical recording apparatus of wherein the EFM input interface generates the address signal according to a previous land section, a current pit section, and a next land section in the EFM modulation waveform (column 4, lines 9-18 and column 5, lines 17-19).

It would have been obvious to one of ordinary skill in the art at the time of the invention to include the clock signal dependencies and generation of the address signal of Kato et al. into the invention of Kaku et al. The given structure of delays provides robust and stable delays that are independent of temperature, voltage, and process variations (column 2, lines 41-43 of Kato et al.). The given structure of generating the address signal allows for programmability of values that are dependent on the CD-RW manufacturer (column 5, lines 20-28 of Kato et al.).

3. Claim 8 is rejected under 35 U.S.C. 103(a) as being unpatentable over Kaku et al. in view of Kato et al., as applied to claim 3 above, and further in view of Chung et al., US Patent 4,873,680.

Kaku et al. in view of Kato et al. teaches the high-speed optical recording apparatus of claim 3. In addition, Kato et al. teaches the high-speed optical recording apparatus wherein the rough delay counter comprises a counter. In column 2, lines 49-51, the EFM data is said to pass through a four stage shift register for a course delay. This is equivalent to passing the data through a four-bit counter for a rough delay.

Although there is no comparator in the system, the rough delay element of 322 in figure 3 takes in the same parameters as the comparator to output the same type of delay signal.

Kato et al. does not specifically teach a comparator to compare the value of the rough delay signal and the output signal of the counter.

Chung et al. teaches in figure 15, a comparison circuit (element 240) connected to a shift register (element 242) for the same general purpose.

It would have been obvious to one of ordinary skill in the art at the time of the invention to include the concept of the given shift register as taught by Chung et al. into the system of Kaku et al. in view of Kato et al. This would serve the purpose of increasing accuracy and reliability of data storage and retrieval (column 2, lines 36-40 of Chung et al.).

#### ***Response to Arguments***

4. Applicant's arguments filed 7/19/06 have been fully considered but they are not persuasive. The argued features are primarily directed towards the specification and not the claims. As for the reference that the rough delay parameter and fine delay parameter is generated by part of element 114 and the write strategy delay table, features of the invention were performed by both elements and thus both were cited.

In response to applicant's argument that the references fail to show certain features of applicant's invention, it is noted that the features upon which applicant relies (i.e., specific output of the adjustment data storage unit or delayed signals in the rough delay element) are not recited in the rejected claim(s). Although the claims are

interpreted in light of the specification, limitations from the specification are not read into the claims. See *In re Van Geuns*, 988 F.2d 1181, 26 USPQ2d 1057 (Fed. Cir. 1993).

In response to applicant's argument that the fine delay chain does not need a clock and that the PLL used to change the frequency of the clock is not the same as a frequency divider as given in claim 4, a recitation of the intended use of the claimed invention must result in a structural difference between the claimed invention and the prior art in order to patentably distinguish the claimed invention from the prior art. If the prior art structure is capable of performing the intended use, then it meets the claim.

Regarding claim 5, column 7, lines 38-52 refer to the calculation/control circuit and explain the necessity of synchronizing the clock signal with the NRZ signal. Thus, both signals must be synchronized.

Regarding claims 6 and 9, the fact that the two clock signals were given with the specifics of Kato et al. for the same purpose proves that they are combinable into the system of Kaku et al. for the reasons given in the rejection.

### ***Conclusion***

5. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Shutoku et al., US Patent Publication 2005/0174911, has a similar implementation of delays. Hsu et al., US Patent Publication 2004/0257949, also teaches similar material. Kando et al., US Patent 6,650,607, uses the NRZI signal for a similar purpose.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Parul Gupta whose telephone number is 571-272-5260. The examiner can normally be reached on Monday through Friday, from 6:30 AM to 4 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Andrea Wellington can be reached on 571-272-4483. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

PHG  
7/26/06



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